Notice of References Cited	Application/Control No. 10/518,915	Applicant(s)/Patent Under Reexamination YANO ET AL.		
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U.S. PATENT DOCUMENTS

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FOREIGN PATENT DOCUMENTS

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	Ν	(N1) JP 2000119156 A	04-2000	Japan	UEHARA et al.	
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NON-PATENT DOCUMENTS

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